


<b>Search Notes</b> 	<b>Application/Control No.</b> 10586029	<b>Applicant(s)/Patent Under Reexamination</b> BISH ET AL.
	<b>Examiner</b> Erich A Leeser	<b>Art Unit</b> 1624

SEARCHED			
Class	Subclass	Date	Examiner
544	358, 359, 360, 362	1-30-08	EL
514	252.12, 252.13, 253.01, 253.09	1-30-08	EL

SEARCH NOTES		
Search Notes	Date	Examiner
STN structure search, PALM inventor search and EAST class search	1-30-08	EL

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
544	358, 359, 360, 362	1-30-08	EL
514	252.12, 252.13, 253.01, 253.09	1-30-08	EL

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